## Application/Control No. Applicant(s)/Patent Under Reexamination 10/761,226 OHTAKE ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Kuang Y. Lin 1725 **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY US-Α В US-US-С D US-US-Ε F US-G US-US-Н ١ US-US-J US-Κ L US-М US-FOREIGN PATENT DOCUMENTS **Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY JP 59-110,455 06-1984 Ν Japan 0 Р Q R S Т **NON-PATENT DOCUMENTS**

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